In re application of:

Group Art Unit:

Clark T.-C. Nguyen, et al.

Examiner:

Serial No.:

10/737,363

Filed:

December 16, 2003

For:

MICROMECHANICAL RESONATOR DEVICE AND

METHOD OF MAKING A MICROMECHANICAL DEVICE

Attorney Docket No.: UOM 0285 PUSP

## INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents U.S. Patent & Trademark Office P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

In compliance with the duty of disclosure under 37 C.F.R. § 1.56 and § 1.97-1.98, the references listed and identified on the attached Forms PTO/SB08A and/or SB08B are being submitted herewith for consideration by the Examiner.

While this Statement is being filed in compliance with the duty of disclosure, citation of the attached references is not to be construed as an admission that any of the reference(s) are "material" as defined under 37 C.F.R. § 1.56(b).

## CERTIFICATE OF MAILING UNDER 37 C.F.R. § 1.8

I hereby certify that this paper, including all enclosures referred to herein, is being deposited with the United States Postal Service as first-class mail, postage pre-paid, in an envelope addressed to: Commissioner for Patents, U.S. Patent & Trademark Office, P.O. Box 1450, Alexandria, VA 22313-1450 on:

March 25, 2004

\_\_\_\_\_ David R. Syrowik

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Atty Dkt No. UOM 0285 PUSP

S/N: 10/737,363

If the filing date of this application is on or before June 30, 2003, a copy of each reference listed on the attached Forms PTO/SB08A and/or SB08B is included herewith. If this application was filed after June 30, 2003, copies of any cited U.S. patent/application references have not been included. Consideration and entry into the record of these references is respectfully requested.

Respectfully submitted,

Clark T.-C. Nguyen, et al.

Bv:

David R. Syrowik Reg. No. 27,956

Attorney/Agent for Applicant

Date: March 24, 2004

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PTO/SB/08A (10-96) [MODIFIED]
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INFORMATION DISCLOSURE				Complete if Known		
				Application Number	10/737,363	
				Filing Date	December 16, 2003	
STATEMENT BY APPLICANT		First Named Inventor	Clark TC. Nugyen, et al.			
				Group Art Unit		
(use as many sheets as necessary)				Examiner Name		
Sheet	1	of	3	Attorney Docket Number	UOM 0285 PUSP	

	U.S. PATENT DOCUMENTS						
Examiner Initials	Cite No.1	U.S. PATENT D	OCUMENT Kind Code <sup>2</sup> (if known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	
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			Foreign Patent Do	cument		Date of Publication	Pages, Columns, Lines, Where Relevant	
Examiner Initials	Cite No.1	Office <sup>3</sup>	Number <sup>4</sup>	Kind Code⁵ ( <i>if known</i> )	Name of Patentee or Applicant of Cited Document	of Cited Document MM-DD-YYYY	Passages or Relevant Figures Appear	Т <sup>6</sup>
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<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹ Unique citation designation number. ² See attached Kinds of U.S. Patent Documents. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵ Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁵ Applicant is to place a check mark here if English language Translation is attached.

Substitute for Form 1449B/PTO				Complete if Known			
				Application Number	10/737,363		
INFORMATION DISCLOSURE				Filing Date	December 16, 2003		
STATEMENT BY APPLICANT				First Named Inventor	Clark TC. Nguyen, et a		
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